

[Fig. 1]

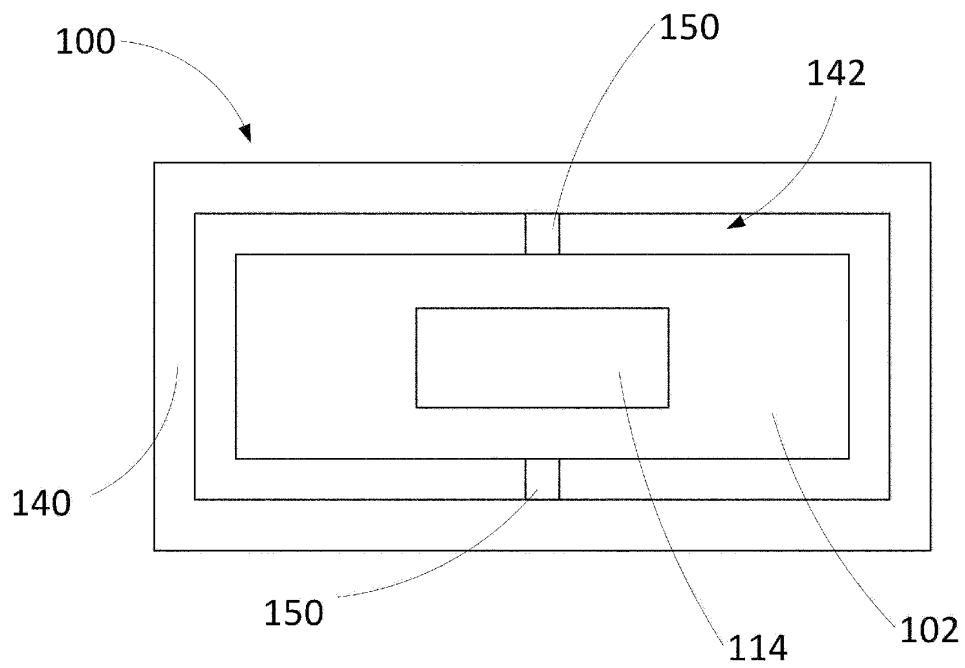


FIG. 1

[Fig. 2]

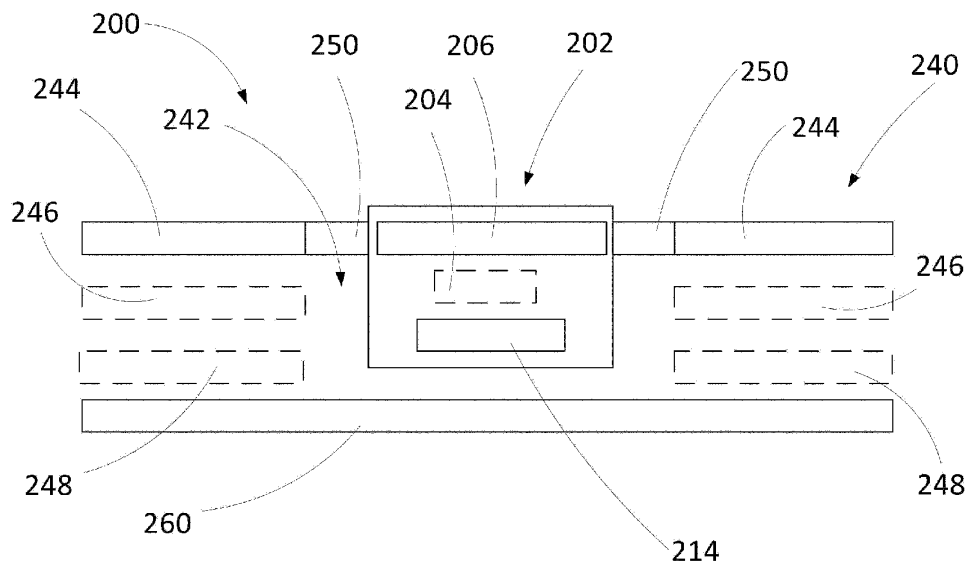
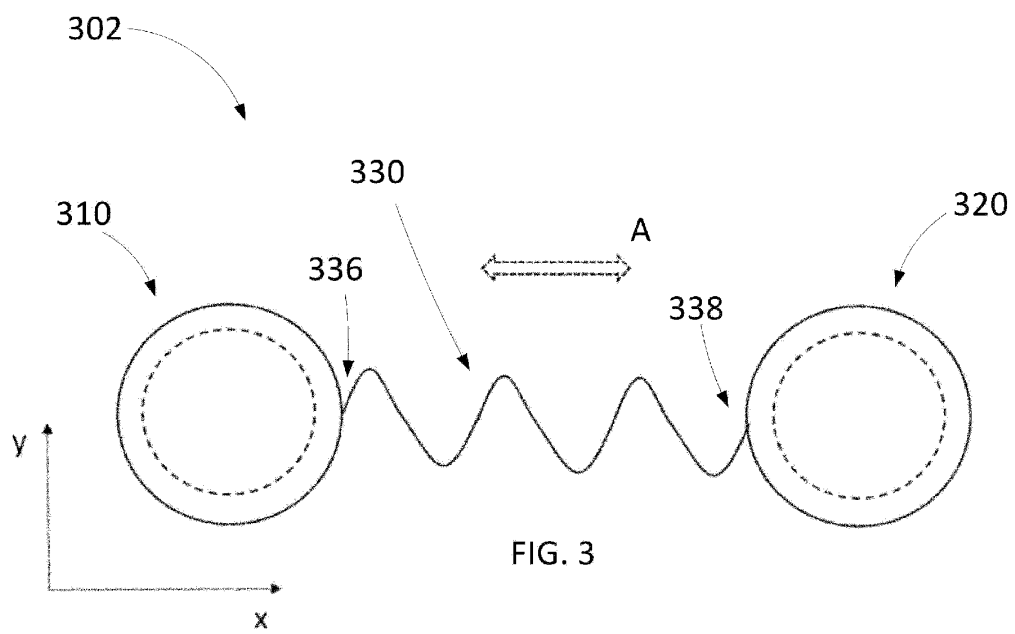
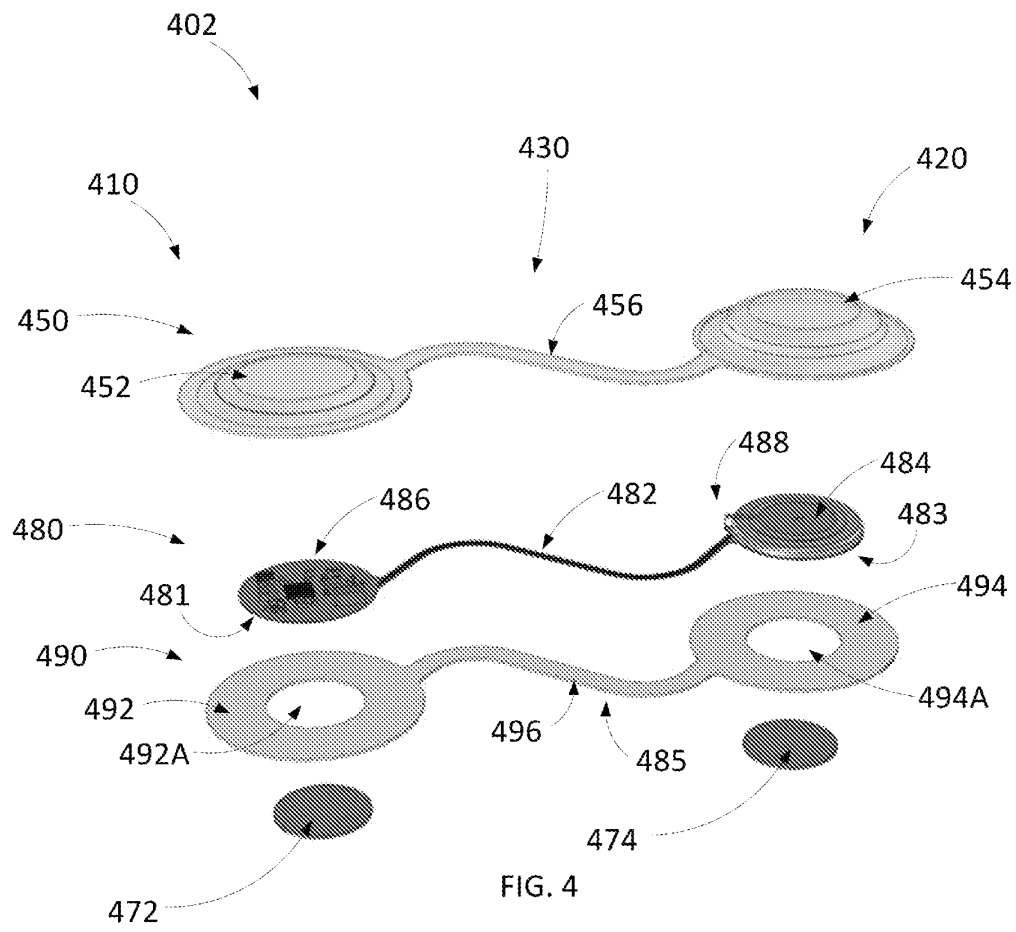


FIG. 2

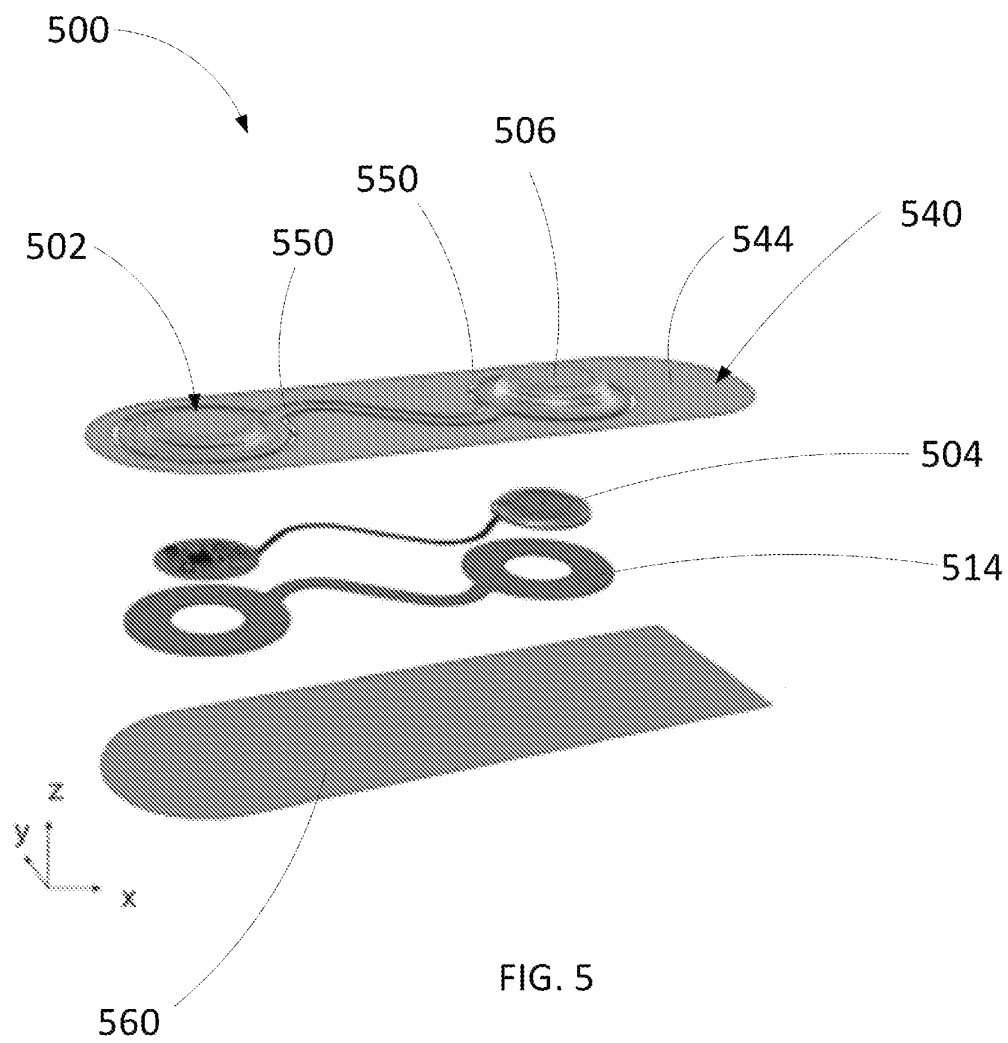
[Fig. 3]



[Fig. 4]



[Fig. 5]



[Fig. 6]

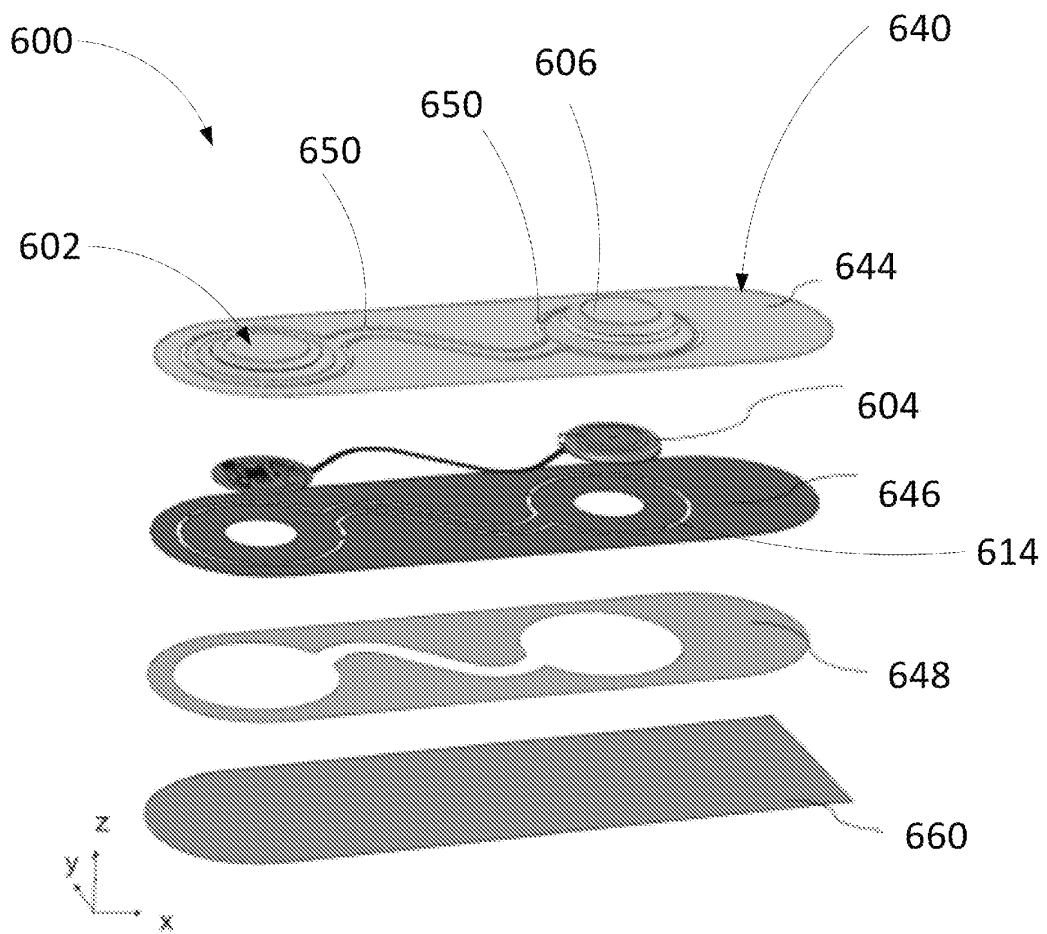


FIG. 6

[Fig. 7A]

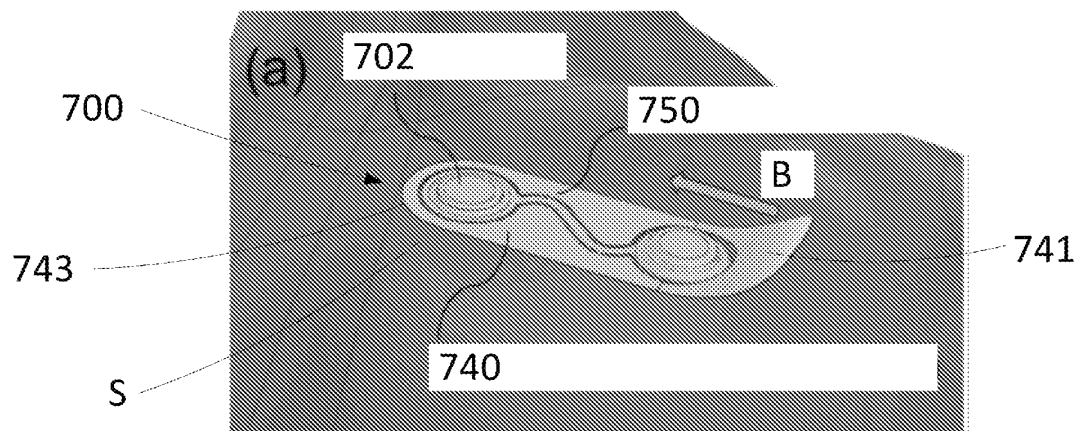


FIG. 7A

[Fig. 7B]

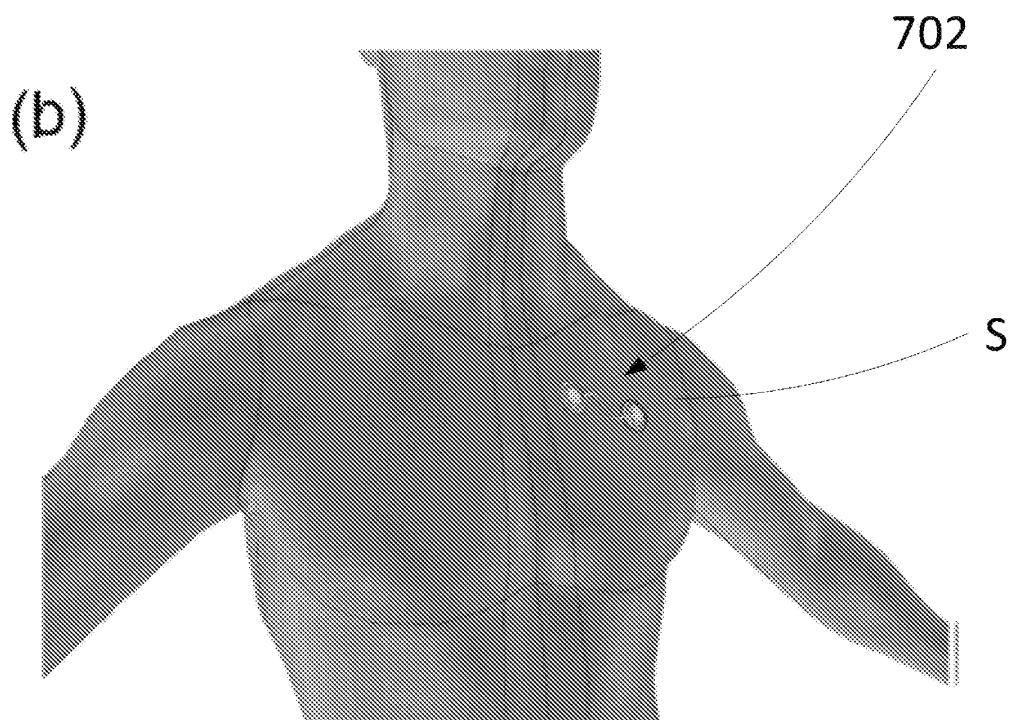


FIG. 7B

[Fig. 8]

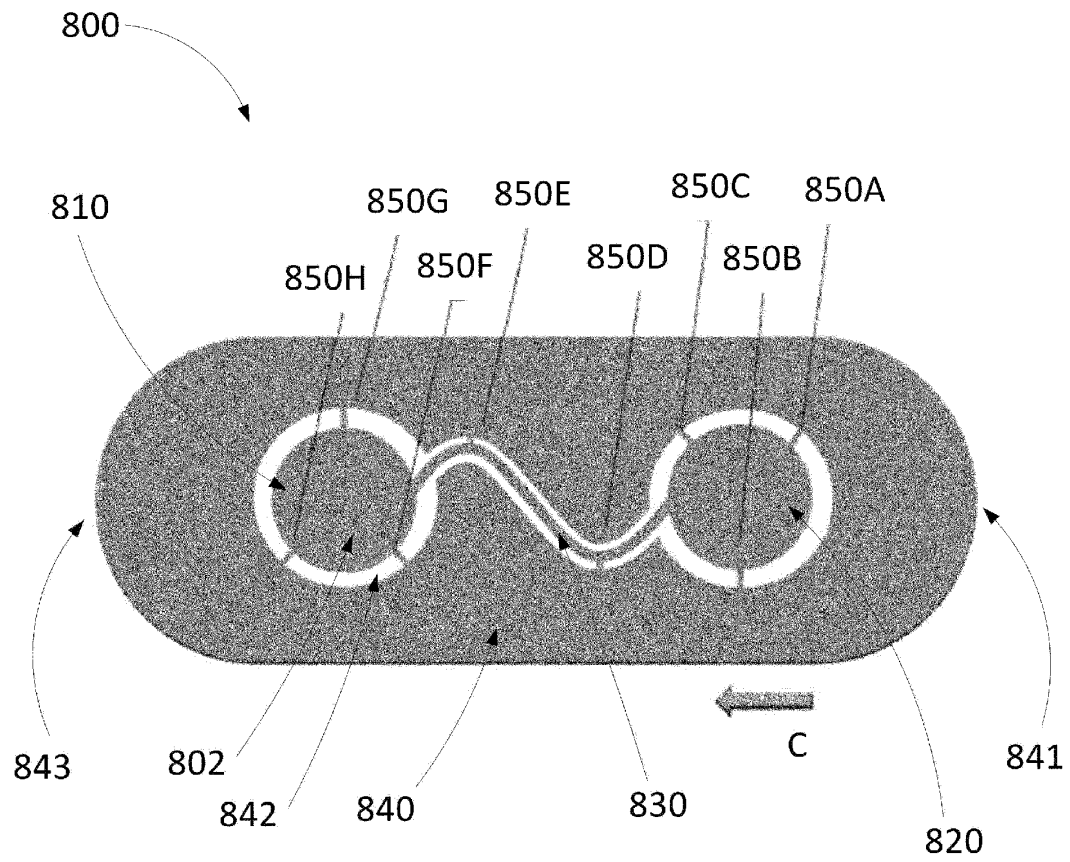


FIG. 8

[Fig. 9]

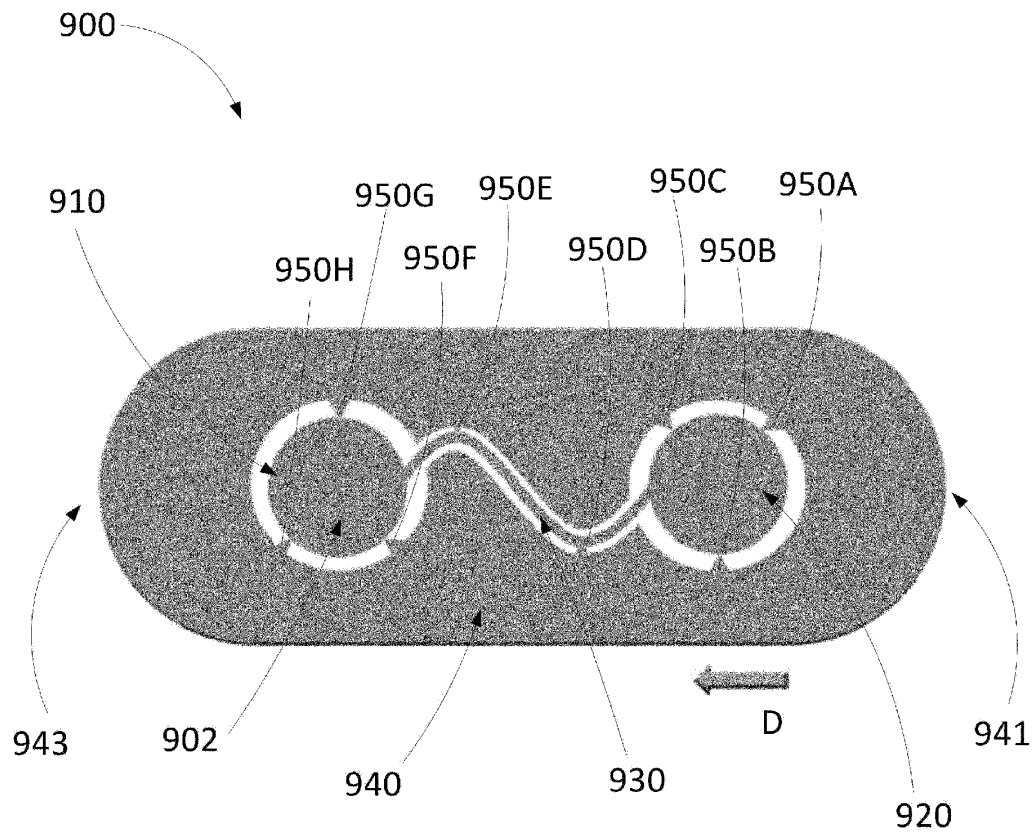


FIG. 9

[Fig. 10]

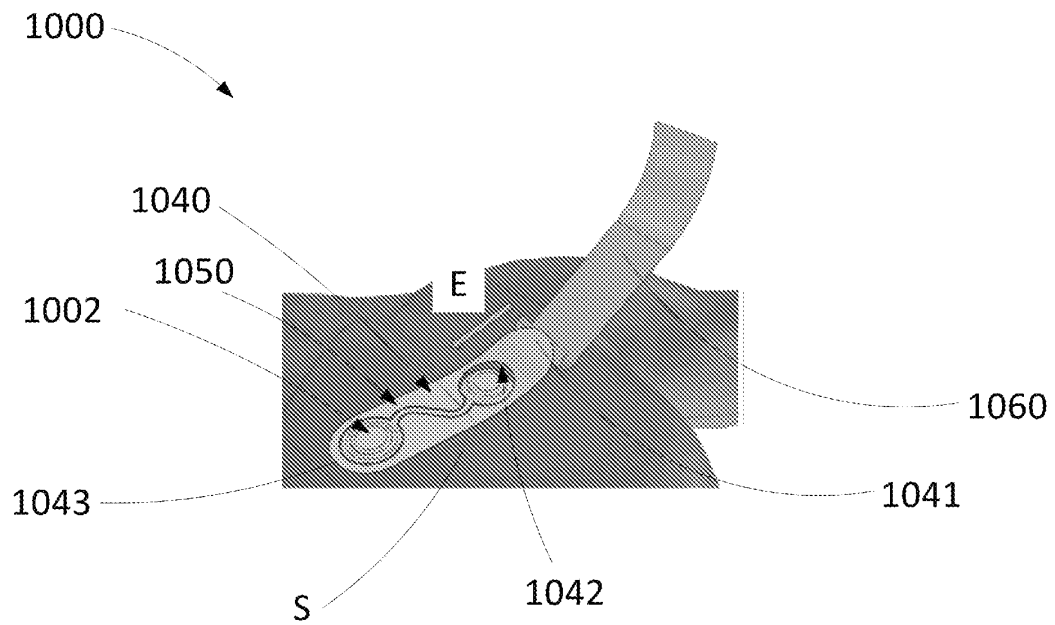


FIG. 10

[Fig. 11A]

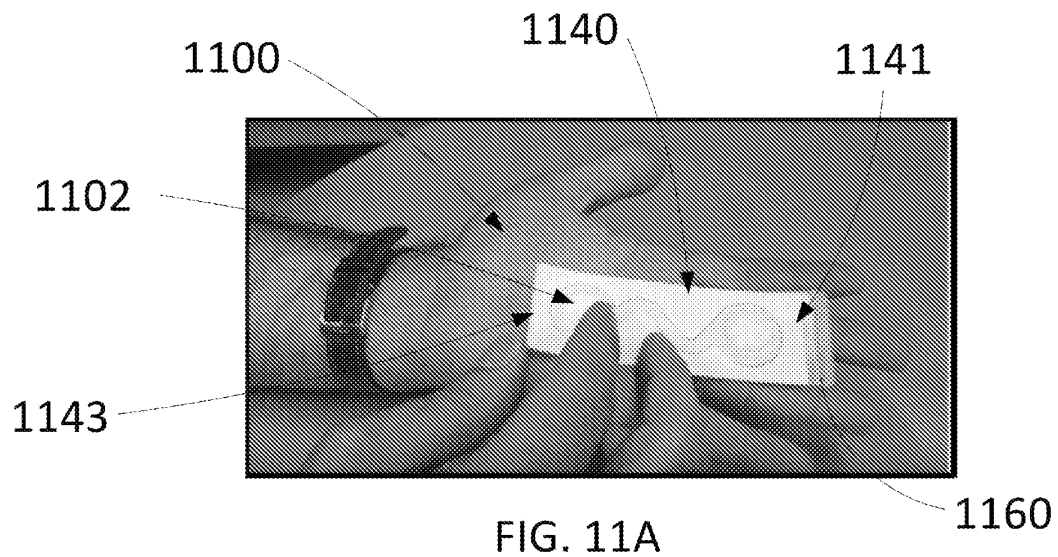


FIG. 11A

[Fig. 11B]

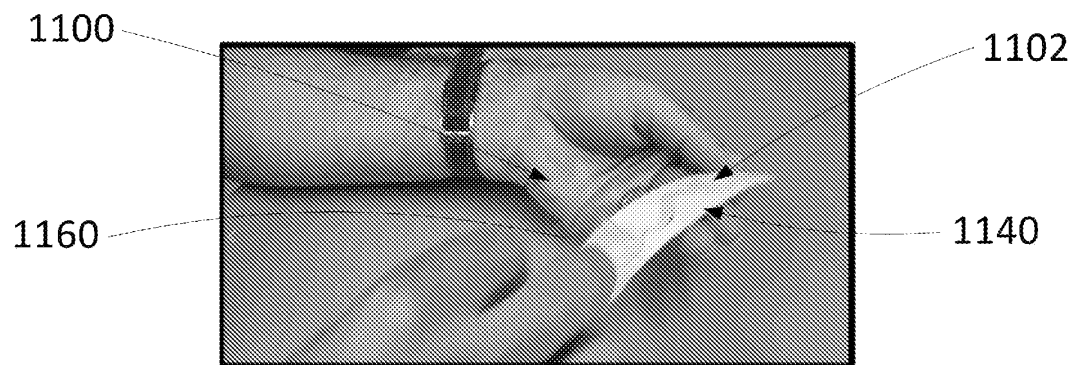


FIG. 11B

[Fig. 11C]

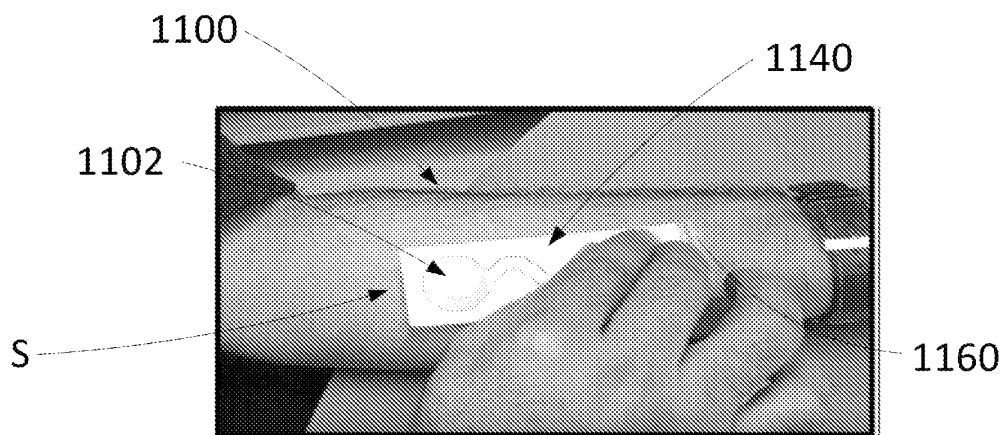


FIG. 11C

[Fig. 11D]

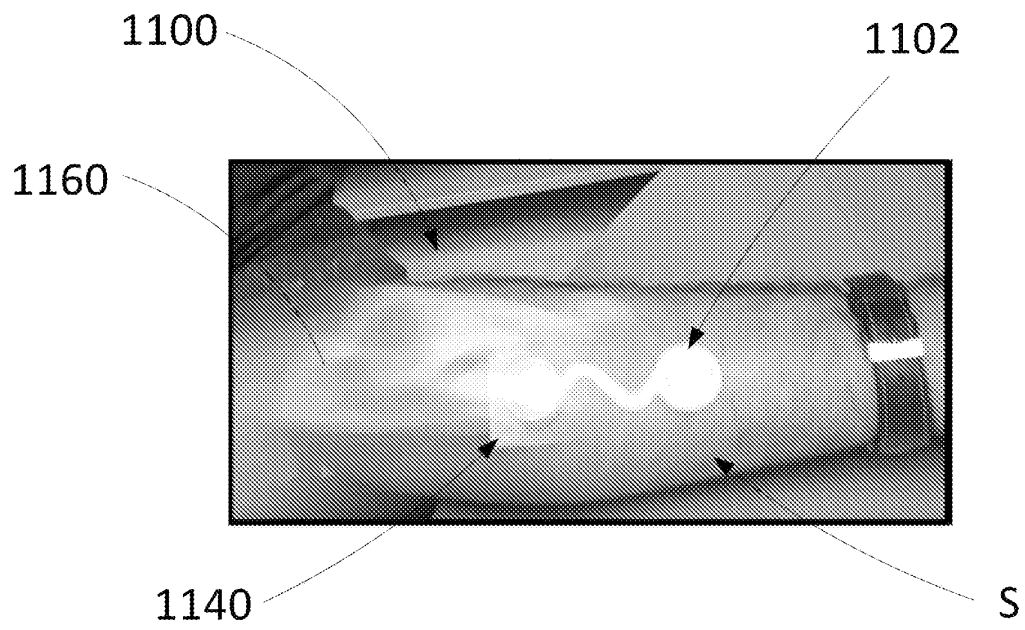


FIG. 11D

[Fig. 11E]

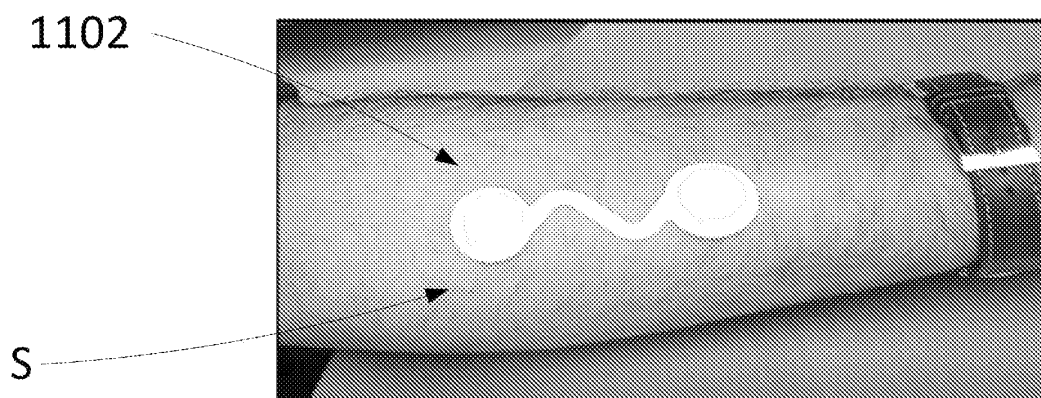


FIG. 11E

[Fig. 12]

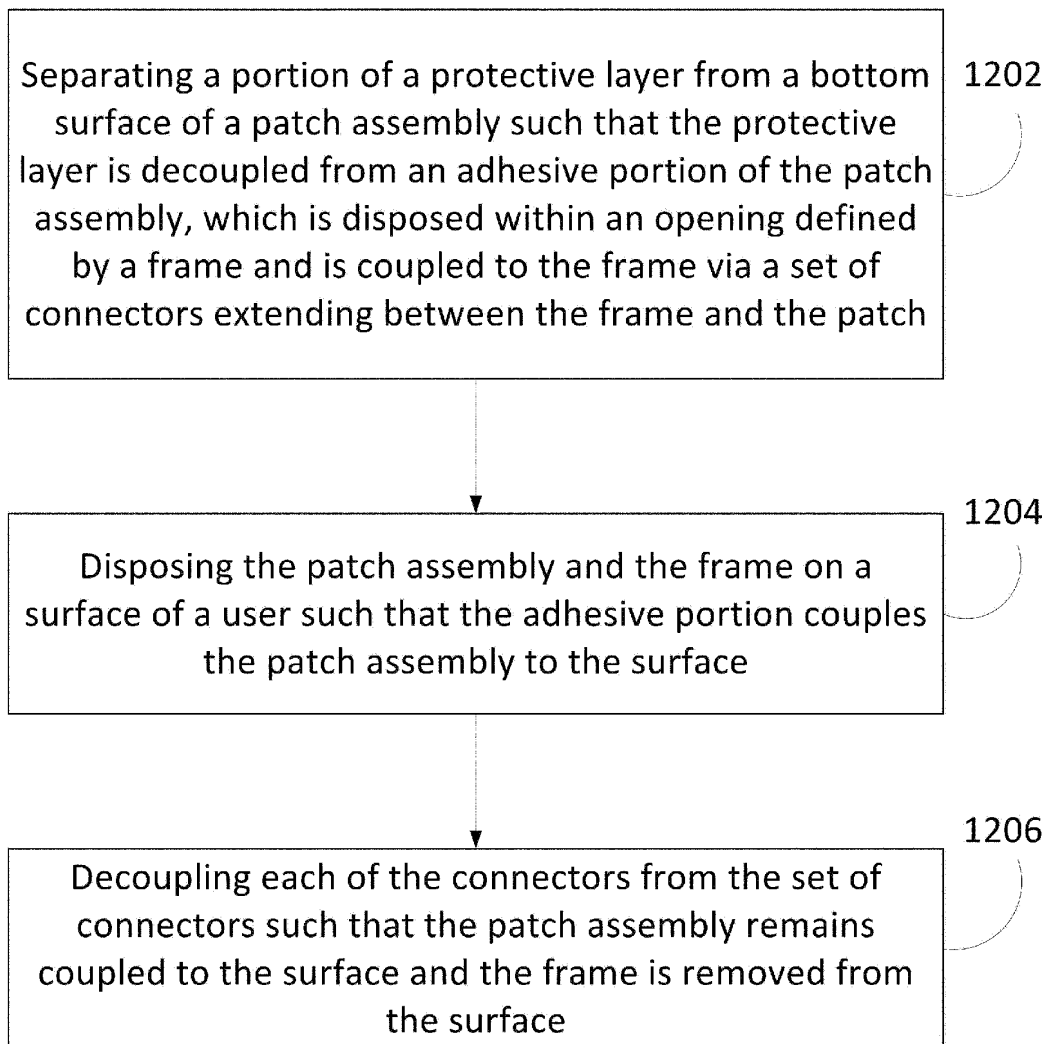
1200

FIG. 12

[Fig. 13]

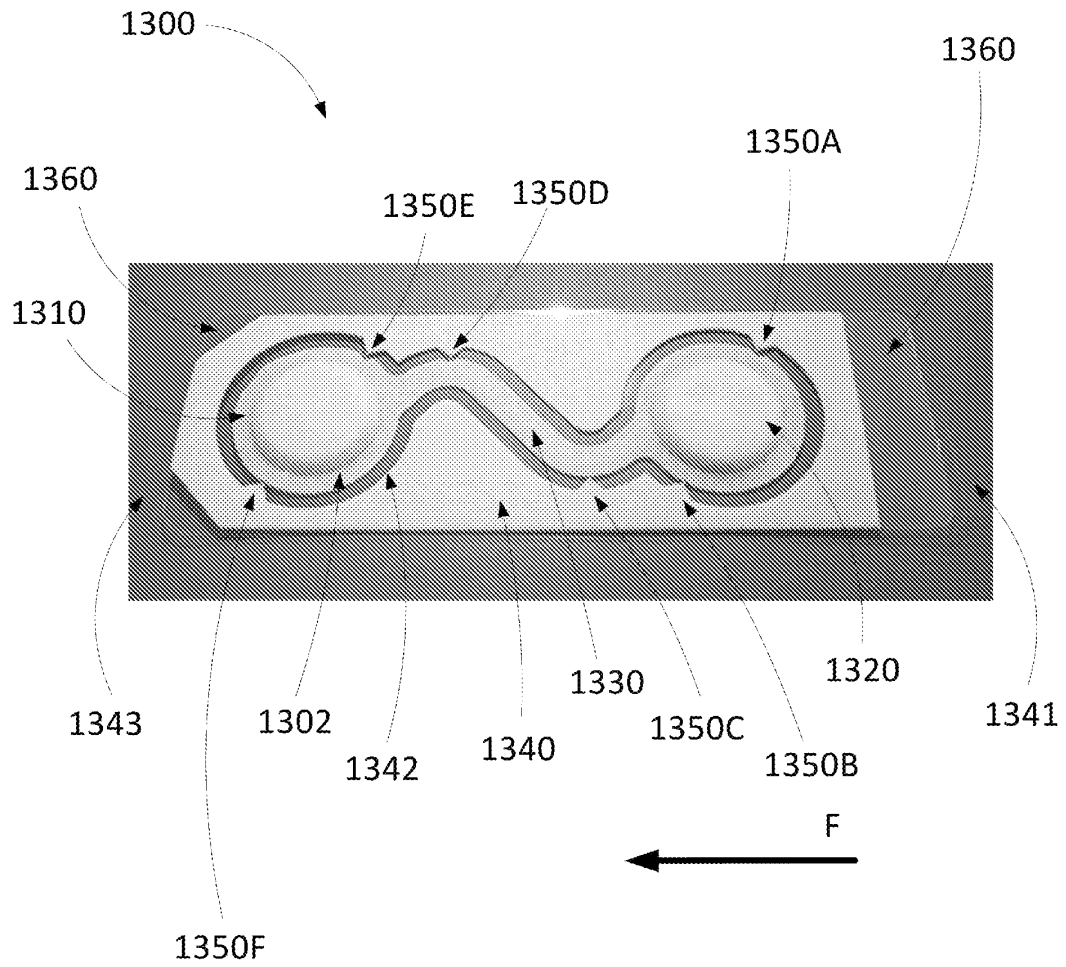


FIG. 13

A micrograph showing a cross-section of a device. The image displays a layered structure with a dark, curved region on the left and a lighter, more uniform region on the right. Several labels with arrows point to specific features: 1310 points to the dark curved region; 1340 points to a horizontal boundary line near the top; 1350E points to a small, dark, irregular feature; 1397 points to the bottom edge of the dark curved region; 1398 points to a small, dark, irregular feature; and 1399 points to a small, dark, irregular feature.

FIG. 14

[Fig. 15]

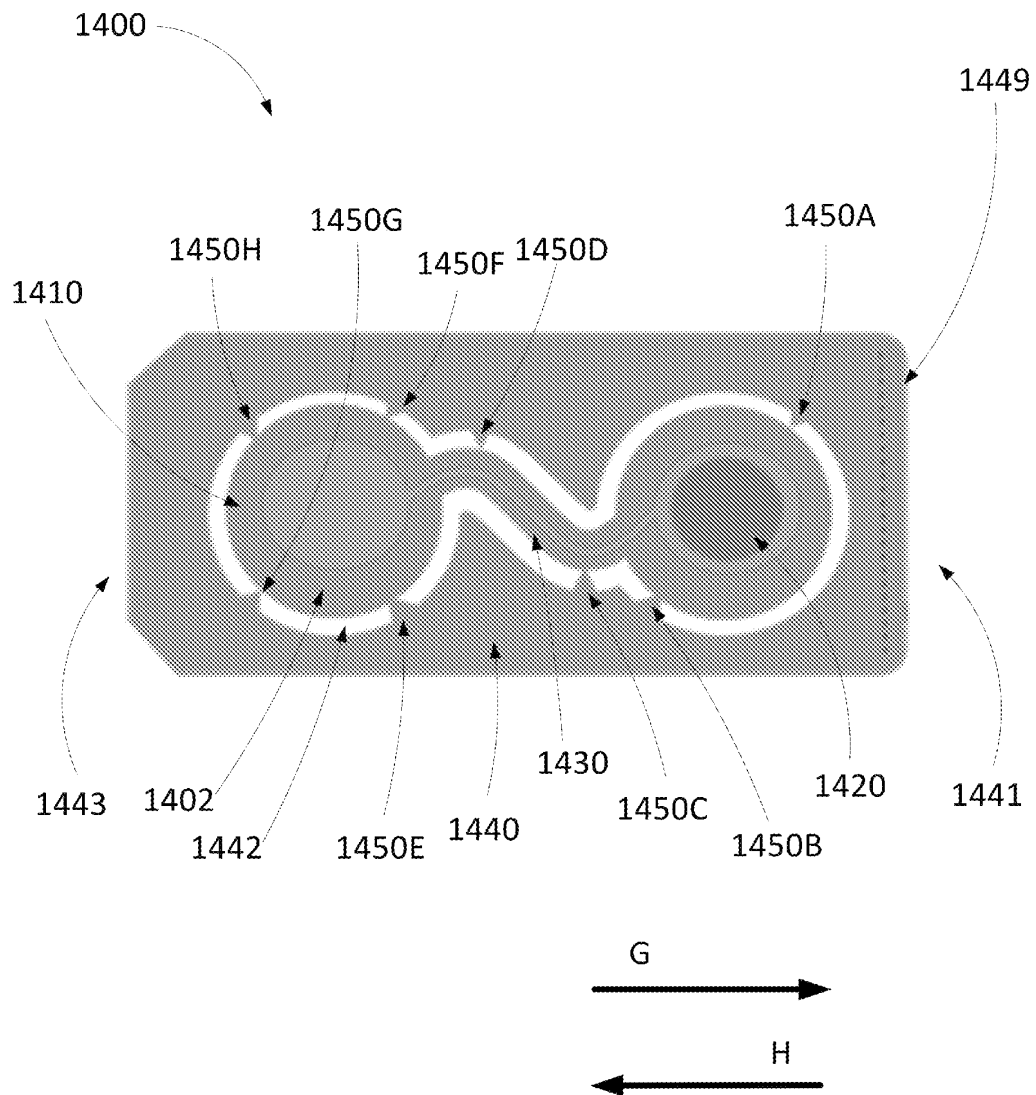


FIG. 15